

# Effect of Film Thickness on the Efficiency of an Electroless Deposited $\text{Cu}_2\text{O}$ Based Solar Cell

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## Abstract

The fabrication of  $n\text{-Cu}_2\text{O}/p\text{-Cu}_2\text{S}$  was successful. The  $n\text{-Cu}_2\text{O}$  layer was deposited on a copper foil using the immersion technique of the electroless chemical deposition method. The prepared  $n\text{-type Cu}_2\text{O}$  samples were grouped into two: the "as-grown" and the annealed; various deposition time and concentration of 0.001M and 0.01M with a pH 9.83 of deposition time 10, 15, 20, 25, 30, 35 and 40 days respectively was used in the same deposition process. At lower deposition time, the samples shows no reaction with both concentrations. The deposition was observed to have begun at the deposition time of 25 days at the 0.001M Conc. and at 20 days for 0.01M Conc. while the formation of the  $n\text{-type cuprous oxide (n-Cu}_2\text{O)}$  was at the deposition time of 30 days for both concentrations. However, at 35 to 40 days the  $n\text{-type cuprous oxide (n-Cu}_2\text{O)}$  layer turned into cupric oxide ( $\text{CuO}$ ). Afterward, the  $n\text{-Cu}_2\text{O}$  was sulphided using  $\text{Na}_2\text{S}$  to create the  $p\text{-Cu}_2\text{S}$  thereby fabricating the  $n\text{-Cu}_2\text{O}/p\text{-Cu}_2\text{S}$  solar cell. Annealing treatment was given to the solar cell at temperature  $T= 300^\circ\text{C}$  for time  $t= 15$  minutes for each of the concentrations. The dependence of efficiency of the solar cell on the oxide film thickness was established. The efficiency was found to increase as the oxide film- thickness decreases up to a limiting thickness of  $4.50\mu\text{m}$  after which the efficiency decreases with decrease in the oxide film thickness.

**Key Words:** Deposition Time, Electroless,  $n\text{-type Cu}_2\text{O}$ ,  $p\text{-Cu}_2\text{S}$ , Efficiency, Annealing

## 1.0 Introduction

Despite the complicated fabrication process and high cost, the majority of solar cells fabricated today are silicon-based solar cells which are single crystalline, large-grained poly crystalline and amorphous forms and they dominated PV market by taking 85% of share (Wang *et al.*, 2007). Silicon is an abundant material, however the purification of the starting material is highly expensive. Therefore to have more cost effective solar cells, silicon should be replaced by other materials. The quest for solution to these problems has led researchers to synthesize and characterize copper oxide materials that are readily available, non-toxic and of low cost of fabrication compared to the silicon based solar cells (Abdul *et al.*, 2009). The current debate over copper oxides semiconductors is the low efficiency records of the solar cells fabricated with the cuprous oxide based material (Mateen, 2008; Yunusa *et al.*, 2014). Several authors have prepared and studied copper oxides materials to fabricate solar cell devices using different methods, such copper oxides includes Cuprous oxide ( $\text{Cu}_2\text{O}$ ) and Cupric oxide ( $\text{CuO}$ ) (Kidowaki, *et al.*, 2011; Abdul *et al.*, 2009; Mittiga, 2006; Ibrahim *et al.*, 2015).

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In this research, the Electroless Chemical Deposition method which involves the use of immersion technique will be employed to synthesize n-type Cu<sub>2</sub>O which is an absorber layer for the fabrication of p-n homojunction solar cell. Deposition is performed in solution; the pH of the solution determines conduction type of the formed film. The research investigates the effect of deposition time on thickness of an electroless n-type Cu<sub>2</sub>O and consequently determine the dependence of the efficiency of the solar cell on the oxide film thickness. Several chemical methods for the deposition of Cu<sub>2</sub>O layers are available. Of the various techniques the electroless deposition or autocatalytic method is an attractive method that involves the presence of a chemical reducing agent in solution to reduce metallic ions to the metal state, (Awodugba *et al.*, 2011). The name electroless is somewhat misleading, however, there are no external electrodes present, but there is electric current (charge transfer) involved. Instead of an anode, the metal is supplied by the metal salt and a substrate serves as the cathode, while the electrons are provided by a reducing agent. The process takes place only on catalytic surfaces rather than throughout the solution (if the process is not properly controlled, the reduction can take place throughout the solution, possibly on particles of dust or of catalytic metals, with undesirable results) (Mordechay, 2010). Electroless deposition possesses several characteristics not shared by other methods, and that accounts for its ever-growing popularity. Experience shows that each substrate requires its own specific technique and surface preparation (i.e. cleaning process) which requires very careful selection and application. It must be stressed that cleaning may affect the porosity of the metal deposit (Abdel *et al.*, 2007). Residues from cleaners and deoxidizers may create inactive spots that will not initiate electroless deposition. This may result in the necessity to have a thicker deposit before continuity is achieved. In extreme cases continuity is never reached. In general, deposition requires one or more of the following steps (1) Cleaning, (2) Surface modification, (3) Sensitization, (4) Catalyzing, (5) Activation (acceleration). Rinsing is required between the steps. If the metal to be deposited electrolessly can be reduced by the sensitizing ion, then it is not necessary to reduce the active metal first. Instead, the substrate is immersed in the electroless bath immediately after sensitizing and rinsing, (Heaven, 1970).

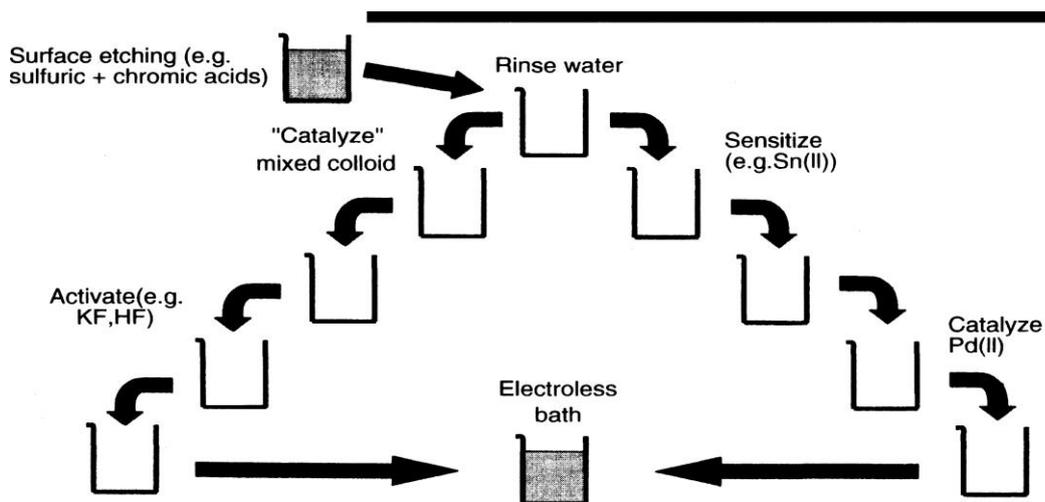
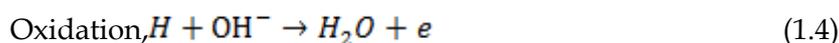
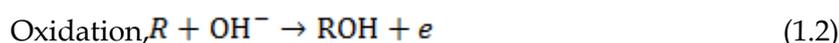
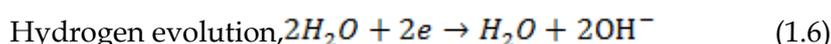
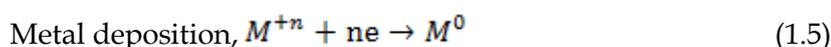


Figure 1.1: Schematic representation of the electroless deposition process. (Abdel *et al.*, 2007)

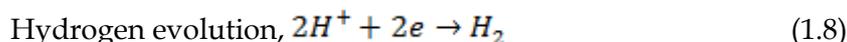
According to Van Den Meerakker and Paunovic (2010), electroless deposition processes may be viewed and understood by what is referred to as a universal electrochemical mechanism regardless of the nature of the many possible reducing agents R. Each process can be viewed as made up of a series of elementary anodic and cathodic reactions. The first anodic stage is the dehydrogenation of the reductant. Thus the following four anodic stages are recognized in the case of alkaline media:



In the case of alkaline media the following two cathodic stages are recognized:



In acid media stages 4 and 6 are to be written as follows:



Various approaches have been used in depositing *n* - Cu<sub>2</sub>O layer, some of which include the boiling technique (Yunusa *et al.*, 2014), the heating or chemical bath techniques (Ibrahim *et al.*, 2016), the electrochemical deposition technique (Kunhee *et al.*, 2009; Longeheng *et al.*, 2007). In this research work the approach used is the Electroless Chemical Deposition method via the immersion technique, with an attempt to study the effect of varying the concentration of the metal salts and to determine the dependency of efficiency of the solar cell on the oxide film thickness.

## 2.0 Experimental Procedure

Electroless Deposition Method was used. A good quality copper foil was used as the substrate, the copper foil surface was first conditioned in accordance with the existing procedure (Musa *et al.*, 1998). This eliminates any grease or dirt from the surface of the copper foil. The copper sheets (0.1mm thickness, and 99.99% purity) were cut into samples of 1cm x 1cm size, and were then smoothened and washed in dilute nitric acid then rinse in a solution of sodium persulphate for 20secs and finally rinsed again in deionized water.

Anhydrous copper II sulphate of purity 99.0% (BDH-GPR), and molecular weight of 159.60 was used to make CuSO<sub>4</sub> solution of concentrations 0.001M and 0.01M respectively. Adventurer Ohaus analytical balance was used to weigh the copper II sulphate, which was dissolved in 500cm<sup>3</sup> of distilled water. The formation of the *n*-type Cu<sub>2</sub>O layers was achieved following the method reported in literature (Yunusa, 2011) which is based on the immersion techniques of the electroless deposition method. In this techniques 100cm<sup>3</sup> each of the 0.001M and 0.001M CuSO<sub>4</sub> solution, at pH = 9.83, was taken in a beaker for uniformity of the deposition condition. The copper plates were then placed into the solution and left for

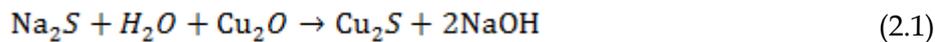
the deposition time of 10,20,30,35 and 40 days respectively. At the end of the stated number of days, the copper foils were removed and washed severally in deionized water and finally dried between tissue papers.

### 2.1 Annaeling

The n- Cu<sub>2</sub>O layers were given heat treatment according to Abdu and Idowu (2014). This heat treatment is called annealing. The annealing process was performed to achieve the following objectives: healing defects created during the deposition, lowering the resistivity of the layers and improving on the grain size of the crystals. The Vecstar furnace heating chamber, Model Spch12 was used for the annealing process. The sample layers were annealed at the same time of t=15min and temperature T=300<sup>o</sup>C to determine the effect of annealing of the samples.

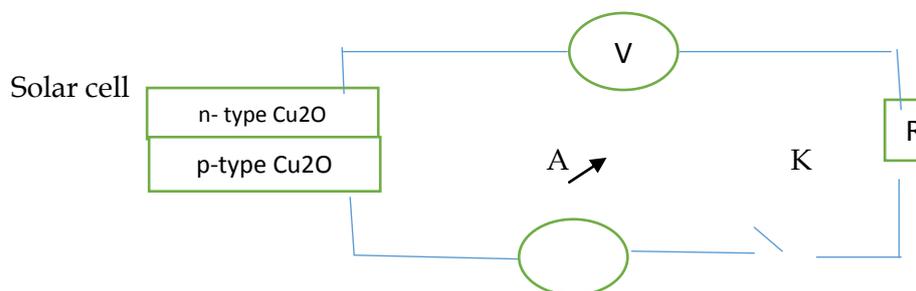
### 2.2 Formation of the p-Cu<sub>2</sub>S Layer

To form a heterojunction solar cell, the formation of the Cu<sub>2</sub>S is necessary to make up with the n-type Cu<sub>2</sub>O formed. Cu<sub>2</sub>S is a p-type material and it's formed on the n-Cu<sub>2</sub>O surface by immersing in Na<sub>2</sub>S for some seconds. The surface of n-Cu<sub>2</sub>O appear black due to the formation of Cu<sub>2</sub>S and the reaction that took place is



### 2.2 Maximum Power Point Determination

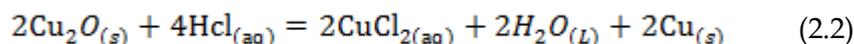
The solar cell fabricated was connected in a circuit as shown in figure 2.1



R was set to zero resistance and the microammeter and Voltmeter readings were noted. This was repeated for values of R= 20Ω, 27Ω, 56Ω, 82Ω, 120Ω, 150Ω, 160Ω and ∞. The experiment was repeated with each of the remaining seven cells connected in place.

### 2.3 Thickness Measurement

The gravimetric method of measurement was used in the setup. In this method the cell samples were weighed on a digital meter balance to obtain the initial mass of the Cu<sub>2</sub>O/Cu which is recorded as M<sub>1</sub> for the different cells. After the initial measurement the Cu<sub>2</sub>O of the cell sample were washed away using concentrated hydrochloric acid to obtain the Cu. The cell samples were re-weighed and recoded as M<sub>2</sub>. The chemical reaction is expressed as



The difference in mass  $M_d = M_1 - M_2$  was calculated for all the samples. Equation (2.2) was used to obtain the thickness of Cu<sub>2</sub>O deposited.

$$t = \frac{M}{A\rho} \quad (2.3)$$

Where t = thickness of the deposited Cu<sub>2</sub>O on Cu, M = mass of Cu<sub>2</sub>O  $\rho$ = density of Cu<sub>2</sub>O which is 6.0gcm<sup>-3</sup>, and A = surface area of the samples which is 0.0001m<sup>2</sup>,

### 3.0 RESULT AND DISCUSSION

#### 3.1 Results

Depending on the deposition time and the concentration of the solution, the physical appearance of the films deposited ranged from blackish-brown to reddish brown and black. Tables 3.1 and 3.2 show the 0.001M and 0.01M concentration of CuSO<sub>4</sub> solution and the measurement of the weights of the sample with the thicknesses after deposition for the annealed and unannealed samples respectively.

**Table 3.1a: Time of deposition, weight difference and thickness of the un-annealed n- Cu<sub>2</sub>O layer**

Cell Sample	Deposition Time(days)	M <sub>1</sub> (g)(weight of Cu <sub>2</sub> O/Cu)	M <sub>2</sub> (g)(weight of Cu)	M <sub>d</sub> (g) = (M <sub>1</sub> -M <sub>2</sub> )	Thickness(μm)	Observation
A <sub>11</sub>	10	-	-	-	-	Shows no Deposition
A <sub>12</sub>	15	-	-	-	-	Shows no Deposition
A <sub>13</sub>	20	-	-	-	-	Shows no Deposition
A <sub>14</sub>	25	0.2250	0.2220	0.0030	5.000	Cu <sub>2</sub> O layer formed
A <sub>15</sub>	30	0.2951	0.2932	0.0019	3.166	Cu <sub>2</sub> O layer formed
A <sub>16</sub>	35	0.2287	0.2237	0.0045	7.500	CuO layer formed
A <sub>17</sub>	40	0.2922	0.2886	0.0036	6.000	CuO layer formed

**Table 3.1b: Time of deposition, weight difference and thickness of the annealed n- Cu<sub>2</sub>O layer**

Cell Sample	Deposition Time(days)	M <sub>1</sub> (g)(weight of Cu <sub>2</sub> O/Cu)	M <sub>2</sub> (g)(weight of Cu)	M <sub>d</sub> (g) = (M <sub>1</sub> -M <sub>2</sub> )	Thickness (μm)	Observation
A <sub>11</sub>	10	-	-	-	-	Shows no Deposition
A <sub>12</sub>	15	-	-	-	-	Shows no Deposition
A <sub>13</sub>	20	-	-	-	-	Shows no Deposition
A <sub>14</sub>	25	0.3070	0.3044	0.0026	4.333	Cu <sub>2</sub> O layer formed
A <sub>15</sub>	30	0.2890	0.2825	0.0065	10.83	Cu <sub>2</sub> O layer formed
A <sub>16</sub>	35	0.2593	0.2552	0.0041	6.833	CuO layer formed
A <sub>17</sub>	40	0.3186	0.3137	0.0049	8.166	CuO layer formed

**Table 3.2a: Time of deposition, weight difference and thickness of the un-annealed Cu<sub>2</sub>O layer**

Cell Sample	Deposition Time(days)	M <sub>1</sub> (g)(weight of Cu <sub>2</sub> O/Cu)	M <sub>2</sub> (g)(weight of Cu)	M <sub>d</sub> (g) = (M <sub>1</sub> -M <sub>2</sub> )	Thickness (μm)	Observation
B <sub>11</sub>	10	-	-	-	-	Shows no Deposition
B <sub>12</sub>	15	-	-	-	-	Shows no Deposition
B <sub>13</sub>	20	0.3015	0.2999	0.0016	2.666	Cu <sub>2</sub> O layer formed
B <sub>14</sub>	25	0.2734	0.2696	0.0038	6.333	Cu <sub>2</sub> O layer formed
B <sub>15</sub>	30	0.2664	0.2632	0.0032	5.333	Cu <sub>2</sub> O layer formed
B <sub>16</sub>	35	0.2813	0.2781	0.0032	5.333	CuO layer formed
B <sub>17</sub>	40	0.3307	0.3276	0.0031	5.166	CuO layer formed

**Table3.2b: Time of deposition, weight difference and thickness of the annealed n- Cu<sub>2</sub>O layer**

Cell Sample	Deposition Time(days)	M <sub>1</sub> (g)(weight of Cu <sub>2</sub> O/Cu)	M <sub>2</sub> (g)(weight of Cu)	M <sub>d</sub> (g) = (M <sub>1</sub> -M <sub>2</sub> )	Thickness (μm)	Observation
B <sub>11</sub>	10	-	-	-	-	Shows no Deposition
B <sub>12</sub>	15	-	-	-	-	Shows no Deposition
B <sub>13</sub>	20	0.2818	0.2805	0.0013	2.166	Cu <sub>2</sub> O layer formed
B <sub>14</sub>	25	0.2938	0.2911	0.0027	4.500	Cu <sub>2</sub> O layer formed
B <sub>15</sub>	30	0.2941	0.2911	0.0030	5.000	Cu <sub>2</sub> O layer formed
B <sub>16</sub>	35	0.2888	0.2854	0.0034	5.666	CuO layer formed
B <sub>17</sub>	40	0.2608	0.2578	0.0030	5.000	CuO layer formed

**Table 3.3: Maximum Power Point for annealed cell sample A<sub>15</sub> with the concentration of 0.001M and deposition time of 30days**

R(Ω)	I(μA)	J(μA/cm <sup>2</sup> )	V(mV)	P(μW)
0	349	87.25	0.0	0.0000
27	280	70.00	30.0	8.4000
56	279	69.75	44.0	12.276
82	206	51.50	38.0	7.8280
120	205	51.25	45.0	9.2250
150	198	49.50	47.0	9.3060
∞	0	00.00	60	0.0000

### 3.2 Energy Conversion Efficiency

#### 3.2.1 Energy conversion efficiency

The electrical power conversion efficiency  $\eta$  of a solar cell is the ratio of the power out,  $P_{max}$  to the total power input,  $P_{in}$  of the light incident on the cell. This is expressed as:

$$\eta = \frac{P_{max}}{P_{in}} \times 100\% = \frac{FF \cdot J_{sc} \cdot V_{oc}}{P_{in}} \times 100\% \quad (3.1)$$

where  $P_{max}$  = maximum power point,  $V_{oc}$  = Open circuit voltage,  $I_{sc}$  = Short circuit current,  $P_{in}$  = Input light irradiance (1000 W/m<sup>2</sup>), FF= Fill Factor and  $\eta$ = Efficiency of the solar cell.

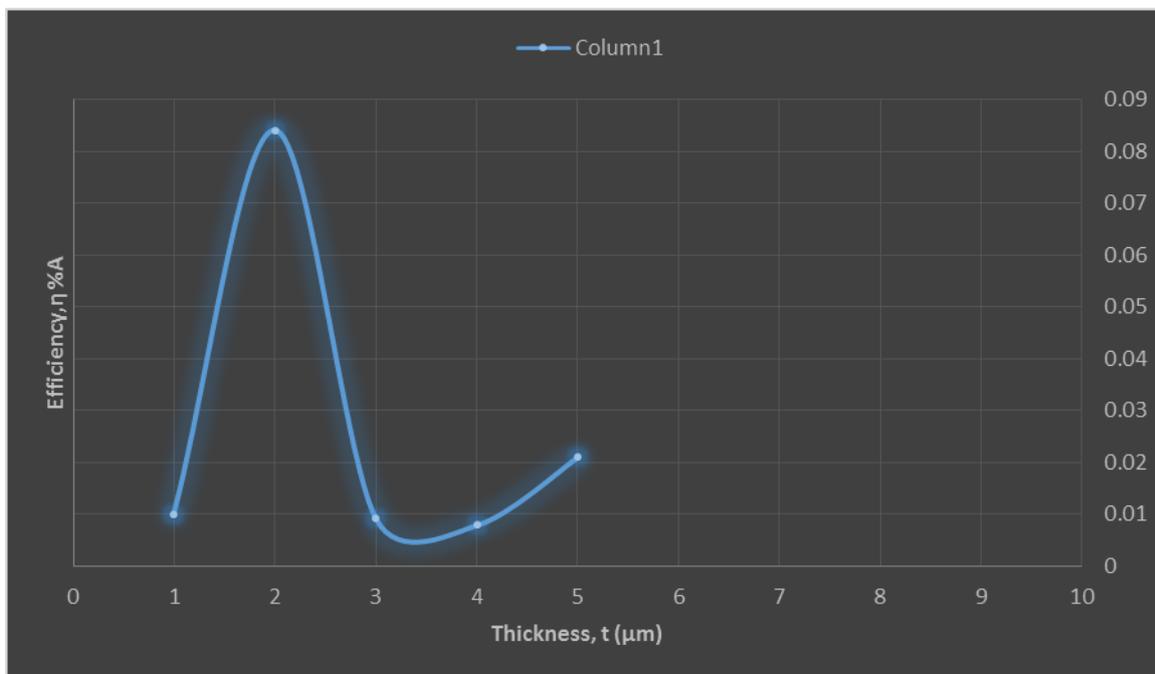
$$FF = \frac{P_{max}}{J_{sc}V_{oc}} = \frac{V_{max}I_{max}}{J_{sc}V_{oc}} \quad (3.2)$$

The Fill Factor (FF) is calculated to be **0.40** using the formula above.

Table 3.4 Variation of the energy conversion efficiency with the thickness of the solar cells for the n-type Cu<sub>2</sub>O layer formed

Cell Sample	Deposition Time (days)	Efficiency (%)x 10 <sup>-2</sup>	Thickness (μm)
B <sub>13</sub>	20	1.00	2.133
A <sub>14</sub>	25	0.78	4.333
B <sub>14</sub>	25	8.40	4.500
B <sub>15</sub>	30	0.92	5.000
A <sub>15</sub>	30	2.09	10.17

Figure 3.1: Plot of energy conversion efficiency against the thickness of Cu<sub>2</sub>O.



### 3.3 Discussion

After all the deposition processes, it was observed that, at deposition time of 10,15 and 20 days there were no deposition for the concentration of 0.001M, while deposition took place at deposition time of 20, and 25 days for the concentration of 0.01M. It is clear from the result that concentration plays an important role with respect to time.

It was observed that n-type Cu<sub>2</sub>O were formed at the deposition time of 20, 25 and 30 days for both concentrations while all deposition formed beyond 30 days shows CuO formation.

Table 3.4 and figure 3.1 shows that the efficiency of the solar cell increase as the thickness of the Cu<sub>2</sub>O decreases up to a limiting thickness of 4.50μm, after which the efficiency decreases as the thickness further decreases.

The limiting thickness of 4.50 $\mu$ m belongs to the cell sample deposited at concentration of 0.01M with deposition time of 25days. The best deposition condition for Cu<sub>2</sub>O on Cu is 0.01M concentration at deposition time of 25days. The short circuit current ( $I_{sc}$ ), the Open circuit voltage ( $V_{oc}$ ), maximum power point ( $P_{max}$ ), Fill Factor (FF), and Efficiency of this solar cells are 280 $\mu$ m, 30mV, 8.400 $\mu$ W, 0.4 and 0.0840%, respectively.

However, the result obtained from the deposition growth, are similar to the result obtained by Yunusa and Idowu (2014). The photo responses of this process depends strongly upon the thickness and concentration of the Cu<sub>2</sub>O solution which have been extensively considered in this work. The method describe is capable of producing an n-type Cu<sub>2</sub>O absorber layer for the fabrication of an efficient homojunction solar cell.

#### **4.0 CONCLUSION**

It was determine that the efficiency of n-Cu<sub>2</sub>O/p-Cu<sub>2</sub>S solar cell depends on the thickness of the Cu<sub>2</sub>O film layer. This shows that the higher the thickness the higher the resistivity and the less efficiency or photo response. In this result the limiting film thickness is 4.50  $\mu$ m, after which the efficiency decreases as the thickness decreases. This is in line with the theoretical support that the efficiency of a solar cell is a function of the number of created electron-hole pair that are able to migrate to the space charged region where they are separated, also the ability of an electron-hole pair to get to the space charged region without recombination depends on the proximity of the creation point to the space charged region.

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